TEST REPORT

Product Name:	Droid820Covid19
Trademark:	N/A
Model Number:	Droid820Covid19
Prepared For:	AOK Displays Manufacturing Co., Ltd
Address:	6th floor, Sanding Commerce buiding, Yangmei, Bantian, Longgang, Shenzhen, China
Manufacturer:	AOK Displays Manufacturing Co., Ltd
Address:	6th floor, Sanding Commerce buiding, Yangmei, Bantian, Longgang, Shenzhen, China
Prepared By:	Shenzhen BCTC Testing Co., Ltd.
Address:	BCTC Building & 1-2F, East of B Building, Pengzhou Industrial, Fuyuan 1st Road, Qiaotou Community, Fuyong Street, Bao'an District, Shenzhen, China
Sample Received Date:	Mar. 15, 2020
Sample tested Date:	Mar. 15, 2020 to May 17, 2020
Issue Date:	Aug. 19, 2020
Report No.:	BCTC2008001665-2E
Test Standards	ETSI EN 301 489-1 V2.2.3 (2019-11) Draft ETSI EN 301 489-17 V3.2.2 (2019-12)
Test Results	PASS
Remark:	This is RED EMC test report.

All test data come from the report of No. BCTC2003001135-2E

Compiled by:	*Reviewed by:*	*Approved by:*
Kelsey Tan	Eric Yang	Zero Zhou/Manager

The test report is effective only with both signature and specialized stamp.This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen BCTC Testing Co., Ltd, this report can't be reproduced except in full.The tested sample(s) and the sample information are provided by the client.

TABLE OF CONTENT

(Note: N/A means not applicable)

1. VERSION

Report No.	Issue Date	Description	Approved
BCTC2008001665-2E	Aug. 19, 2020	Original	Valid

2. TEST SUMMARY

The Product has been tested according to the following specifications:

EMISSION		
Standard	**Test Item**	**Test result**
EN 55032	Conducted emissions from the AC mains power ports	Pass
EN 55032	Asymmetric mode conducted emissions	N/A[1]
EN 55032	Conducted differential voltage emissions	N/A[2]
EN 55032	Radiated emissions	Pass
EN 61000-3-2	Harmonic current emission(H)	N/A[3]
EN 61000-3-3	Voltage fluctuations & flicker(F)	Pass

IMMUNITY		
Standard (EN 55035)	**Test Item**	**Test result**
IEC 61000-4-2	Electrostatic discharge (ESD)	Pass
IEC 61000-4-3	Continuous RF electromagnetic field disturbances(RS)	Pass
IEC 61000-4-4	Electrical fast transients/burst (EFT)	Pass
IEC 61000-4-5	Surges	Pass
IEC 61000-4-6	Radio frequency, common mode	Pass
IEC 61000-4-11	Voltage dips and interruptions (DIPS)	Pass

Remark:
1. The EUT is powered by the DC battery only and has no antenna port, the test item is not applicable.
2. The Product belongs to Class A, and its power is less than 75W, so it deems to fulfil this standard without testing.

3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Test item	Value (dB)
Conducted Emission (150kHz-30MHz)	3.20
Radiated Emission(30MHz~1GHz)	4.80
Radiated Emission(1GHz~6GHz)	4.90

4. PRODUCT INFORMATION AND TEST SETUP

4.1 Product Information

Model(s):	Droid820Covid19
Model Description:	N/A
Hardware Version:	N/A
Software Version:	N/A
Operation Frequency:	Bluetooth: 2402-2480MHz WiFi: IEEE 802.11b/g/n 20: 2412-2472MHz
Max. RF output power:	WiFi (2.4G) : 11.30dBm Bluetooth:2.94 dBm BLE:5.37 dBm
Type of Modulation:	WiFi: DSSS, OFDM Bluetooth: GFSK, Pi/4 DQPSK, 8DPSK BLE:GFSK
Antenna installation:	Internal antenna
Antenna Gain:	1dBi
Ratings:	AC230V/50Hz
Adapter:	Model: GKYPB0300120CN Input: 100-240V ~50/60Hz 1A Max Output: 12V---3A

4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

4.3 Support Equipment

No.	Device Type	Brand	Model	Series No.	Data Cable	Power Cord
1.	Adapter	N/A	GKYPB0300120CN	-	-	DC12V

Notes

1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

4.4 Test Mode

Test item	Test Mode	Test Voltage
Conducted emissions from the AC mains power ports (150KHz-30MHz) Class B	WIFI LINK	AC 230V/50Hz
	PING IP	AC 230V/50Hz*
Radiated emissions(30MHz-6GHz) Class B	WIFI LINK	AC 230V/50Hz
	PING IP	AC 230V/50Hz*
Voltage fluctuations & flicker	WIFI LINK	AC 230V/50Hz
Electrostatic discharge (ESD) ☒Air Discharge: ±2,4,8kV ☒Contact Discharge: ±2,4kV ☒HCP & VCP: ±2,4kV	WIFI LINK	AC 230V/50Hz
	PING IP	AC 230V/50Hz
Continuous RF electromagnetic field disturbances(RS) ☒80MHz-6000MHz , 3V/m,80%	WIFI LINK	AC 230V/50Hz
Electrical fast transients/burst (EFT) ☒1kV AC(Input) ☐0.5kV DC(Input) ☒0.5kV signal,Telec,control	WIFI LINK	AC 230V/50Hz
Surges ☒1kV Line-Line, ☐2kV Line-PE, N-PE ☐0.5kVDC(Input) ☒1KV,☐4KV signal,Telec, control Line-Line:90°+1kV,270°-1kV Line-PE:90°+2kV,270°-2kV N-PE:90°-2kV,270°+2kV	WIFI LINK	AC 230V/50Hz
	PING IP	AC 230V/50Hz
Continuous induced RF disturbances (CS) 0.15MHz to 10MHz 3V,10MHz-30MHz 3 to 1V,30MHz-80MHz 1V ☒ AC(Input) ☐ DC(Input) ☒ signal,control	WIFI LINK	AC 230V/50Hz
	PING IP	AC 230V/50Hz
Voltage dips and interruptions (DIPS) ☒Less 5% 0.5P ☒70% 500ms Voltage Interruptions ☒less5% 5000ms	WIFI LINK	AC 230V/50Hz
	PING IP	AC 230V/50Hz
All test mode were tested and passed, only Conducted Emissions, Radiated Emissions shows (*) is the worst case mode which were recorded in this report.		

4.5 Test Environment

Temperature:	26
Humidity:	54
Atmospheric Pressure:	101kPa

5. TEST FACILITY AND TEST INSTRUMENT USED

5.1 Test Facility

All measurement facilities used to collect the measurement data are located at BCTC Building & 1-2F, East of B Building, Pengzhou Industrial, Fuyuan 1st Road, Qiaotou Community, Fuyong Street, Bao'an District, Shenzhen, China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

5.2 Test Instrument Used

Conducted emissions Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
Receiver	R&S	ESR3	102075	Jun. 13, 2019	Jun. 12, 2020
LISN	R&S	ENV216	101375	Jun. 13, 2019	Jun. 12, 2020
ISN	HPX	ISN T800	S1509001	Jun. 13, 2019	Jun. 12, 2020
Software	Frad	EZ-EMC	EMC-CON 3A1	\	\

Radiated emissions Test (966 chamber)					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
966 chamber	ChengYu	966 Room	966	Jun. 19. 2018	Jun. 18, 2023
Receiver	R&S	ESR3	102075	Jun. 13, 2019	Jun. 12, 2020
Receiver	R&S	ESRP	101154	Jun. 13, 2019	Jun. 12, 2020
Amplifier	Schwarzbeck	BBV9718	9718-309	Jun. 25, 2019	Jun. 24, 2020
Amplifier	Schwarzbeck	BBV9744	9744-0037	Jun. 25, 2019	Jun. 24, 2020
TRILOG Broadband Antenna	schwarzbeck	VULB 9163	VULB9163-942	Jun. 22, 2019	Jun. 21, 2020
Horn Antenna	SCHWARZBECK	BBHA9120D	1201	Jun. 22, 2019	Jun. 21, 2020
Software	Frad	EZ-EMC	FA-03A2 RE	\	\

Harmonic / Flicker Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
Harmonic & Flicker Tester	LAPLAEC	AC2000A	439263	Jun. 13, 2019	Jun. 12, 2020
AC Power Supply	LAPLAEC	PCR4000M	631589	Jun. 13, 2019	Jun. 12, 2020
Software	Frad	EZ-EMC	FA-03A2 RE	\	\

Electrostatic discharge Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
ESD Tester	KIKISUI	KES4201A	UH002321	Jul. 12, 2019	Jul. 10, 2020

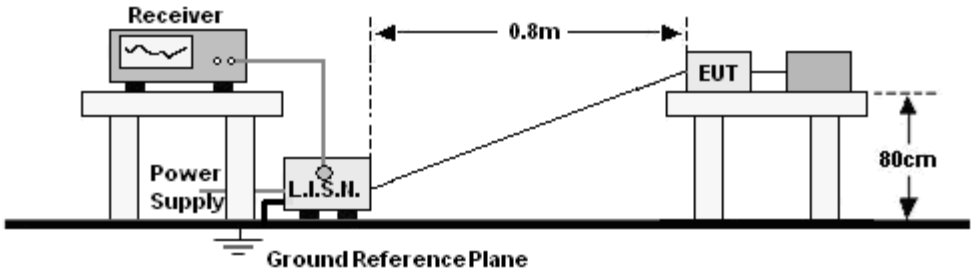
Continuous RF electromagnetic field disturbances Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
Power meter	Keysight	E4419B	GB42421440	Jun. 17, 2019	Jun. 16, 2020
Power sensor	Keysight	E9300A	US39211305	Jun. 17, 2019	Jun. 16, 2020
Power sensor	Keysight	E9300A	US39211659	Jun. 17, 2019	Jun. 16, 2020
Amplifier	SKET	HAP-801000M-250W	\	Jun. 25, 2019	Jun. 24, 2020
Amplifier	SKET	HAP-801000M-75W	\	Jun. 25, 2019	Jun. 24, 2020
Amplifier	SKET	HAP-801000M-50W	\	Jun. 25, 2019	Jun. 24, 2020
Stacked double Log.-Per. Antenna	Schwarzbeck	STLP 9129	077	\	\
Field Probe	Narda	EP-601	80256	Jul. 07, 2019	Jul. 06, 2020
Signal Generator	Aglilent	N5181A	MY50143748	Jun. 13, 2019	Jun. 12, 2020
Software	SKET	EMC-S	1.2.0.18	\	\

EFT and Surge and Voltage dips and interruptions Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
Compact Generator	TRANSIENT	TRA2000	646	Jun. 14, 2019	Jun. 13, 2020
Coupling Clamp	PARTNER	CN-EFT1000	CN-EFT1000-1624	Jun. 27, 2019	Jun. 26, 2020

Continuous induced RF disturbances Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
C/S Test System	SCHLODER	CDG-6000-75	126B1405/2016	Jun. 13, 2019	Jun. 12, 2020
Attenuator	SCHLODER	6DB DC-1G	HA1630	Jun. 13, 2019	Jun. 12, 2020
CDN	SCHLODER	CDN M2/M3	A2210389/2016	Jun. 13, 2019	Jun. 12, 2020
Injection Clamp	SCHLOBER	EMCL-20	132A1272/2016	Jun. 13, 2019	Jun. 12, 2020
Software	HUBERT	HUBERT EN 61000-4-6	1.4.1.0	\	\

6. CONDUCTED EMISSIONS

6.1 Block Diagram Of Test Setup



6.2 Limit

Limits for Conducted emissions at the mains ports of Class B MME

Frequency range (MHz)	Limits dB(μV)	
	Quasi-peak	Average
0,15 to 0,50	66 to 56*	56 to 46*
0,50 to 5	56	46
5 to 30	60	50

Notes: 1. *Decreasing linearly with logarithm of frequency.
2. The lower limit shall apply at the transition frequencies.

Limits for asymmetric mode conducted emissions of Class B MME

Frequency range (MHz)	Voltage Limits dB(μV)		Current Limits dB(μA)	
	Quasi-pea	Average	Quasi-pea	Average
0,15 to 0,50	84-74	74-64	40-30	30-20
0,50 to 30	74	64	30	20

Notes: *Decreasing linearly with logarithm of frequency.

6.3 Test procedure

For mains ports:

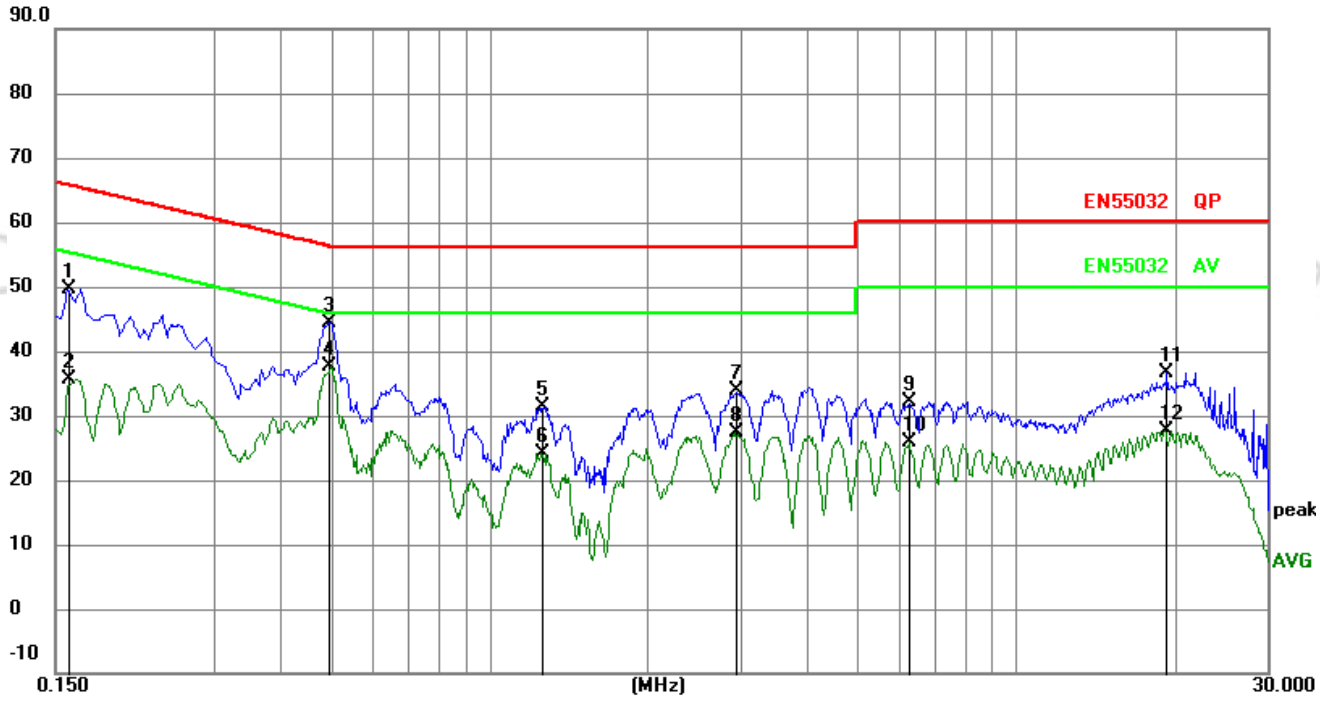
a. The Product was placed on a nonconductive table 0.8 m above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the main through Line Impedance Stability Network (L.I.S.N).

b. The RBW of the receiver was set at 9 kHz in 150 kHz ~ 30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.

c. For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.

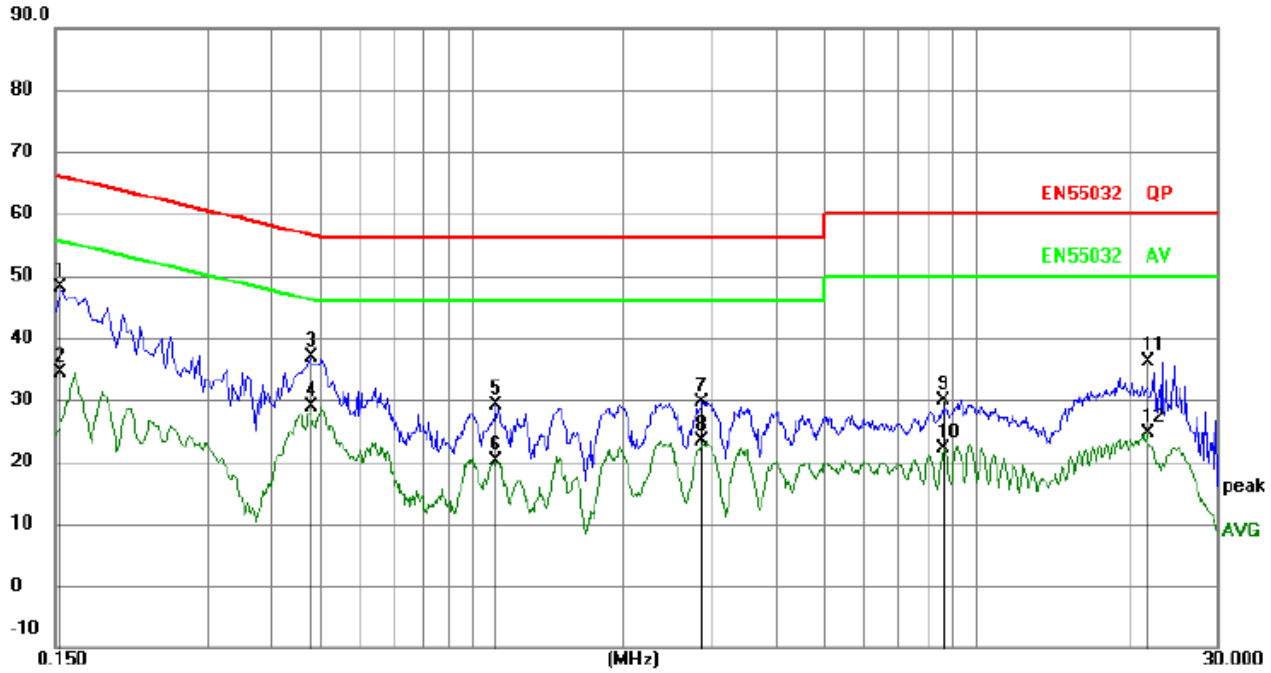
6.4 Test Result

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Phase :	L
Test Mode	PING IP	Remark:	N/A



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over	
		MHz		dB	dBuV	dBuV	dB	Detector
1		0.1590	40.15	9.51	49.66	65.52	-15.86	QP
2		0.1590	26.19	9.51	35.70	55.52	-19.82	AVG
3		0.4965	34.80	9.59	44.39	56.06	-11.67	QP
4	*	0.4965	28.01	9.59	37.60	46.06	-8.46	AVG
5		1.2570	21.73	9.58	31.31	56.00	-24.69	QP
6		1.2570	14.57	9.58	24.15	46.00	-21.85	AVG
7		2.9355	24.17	9.66	33.83	56.00	-22.17	QP
8		2.9355	17.78	9.66	27.44	46.00	-18.56	AVG
9		6.2565	22.29	9.75	32.04	60.00	-27.96	QP
10		6.2565	16.24	9.75	25.99	50.00	-24.01	AVG
11		19.1490	26.82	9.77	36.59	60.00	-23.41	QP
12		19.1490	17.90	9.77	27.67	50.00	-22.33	AVG

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Phase :	N
Test Mode	PING IP	Remark:	N/A

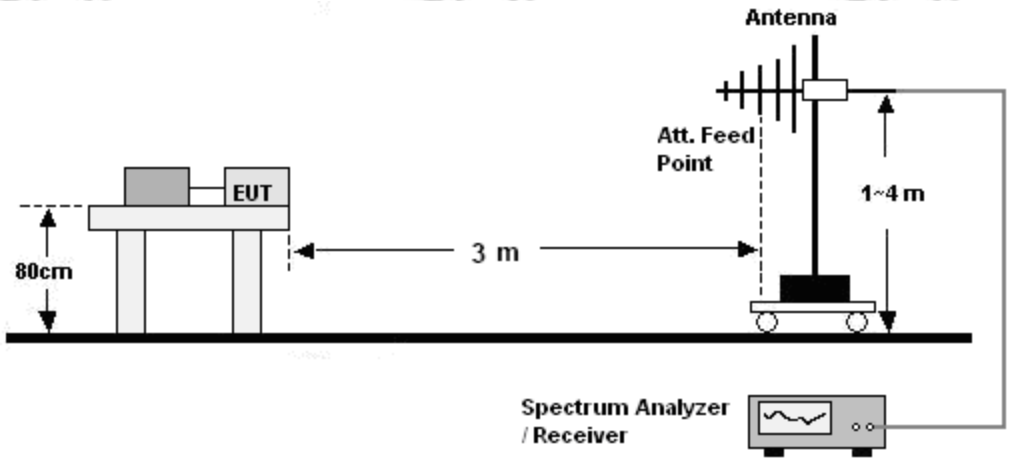


No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over	
		MHz		dB	dBuV	dBuV	dB	Detector
1		0.1539	38.53	9.52	48.05	65.79	-17.74	QP
2		0.1539	24.77	9.52	34.29	55.79	-21.50	AVG
3		0.4812	27.36	9.57	36.93	56.32	-19.39	QP
4	*	0.4812	19.26	9.57	28.83	46.32	-17.49	AVG
5		1.1173	19.60	9.57	29.17	56.00	-26.83	QP
6		1.1173	10.46	9.57	20.03	46.00	-25.97	AVG
7		2.8692	19.95	9.65	29.60	56.00	-26.40	QP
8		2.8692	13.76	9.65	23.41	46.00	-22.59	AVG
9		8.6373	20.12	9.70	29.82	60.00	-30.18	QP
10		8.6373	12.47	9.70	22.17	50.00	-27.83	AVG
11		21.8303	26.33	9.77	36.10	60.00	-23.90	QP
12		21.8303	14.97	9.77	24.74	50.00	-25.26	AVG

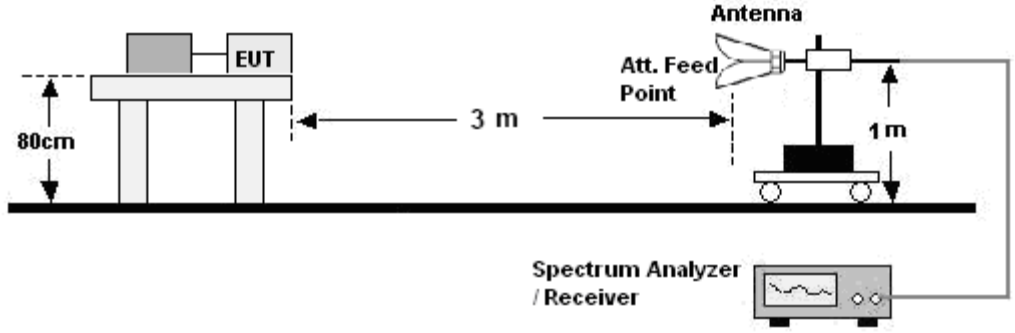
7. RADIATED EMISSIONS TEST

7.1 Block Diagram Of Test Setup

30MHz ~ 1GHz:



Above 1GHz:



7.2 Limits

Limits for radiated disturbance of Class B MME

Frequency (MHz)	Quasi-peak limits at 3m dB(μV/m)	
30-230	40	
230-1000	47	
Frequency (GHz)	limit above 1G at 3m dB(μV/m)	
	Average	peak
1-3	50	70
3-6	54	74

Note: The lower limit shall apply at the transition frequencies.

7.3 Test Procedure

30MHz ~ 1GHz:

a. The Product was placed on the nonconductive turntable 0.8m above the ground in a semi anechoic chamber.

b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.

c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

Above 1GHz:

a. The Product was placed on the non-conductive turntable 0.8 m above the ground in a full anechoic chamber..

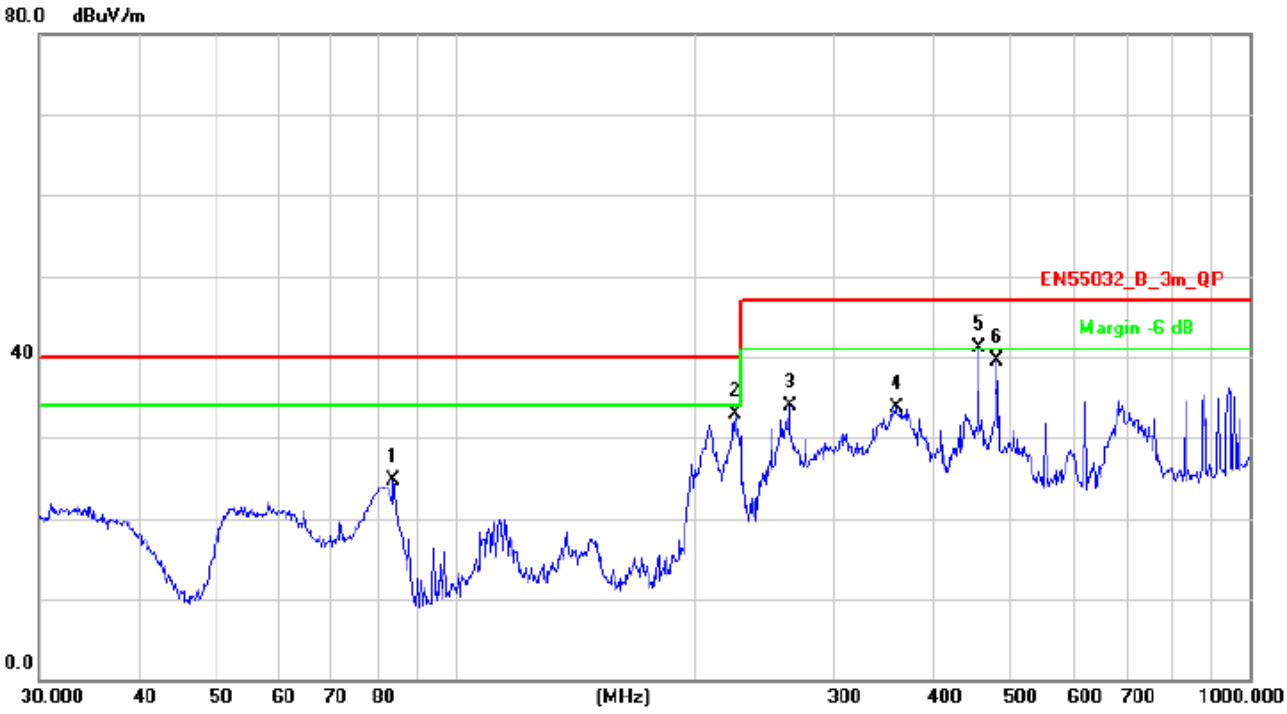
b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.

c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

7.4 Test Results

Below 1GHz

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Polarization :	Horizontal
Test Mode	PING IP	Remark:	N/A



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over	
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB	Detector
1		83.8156	38.74	-14.05	24.69	40.00	-15.31	QP
2		225.3078	43.25	-10.43	32.82	40.00	-7.18	QP
3		263.8190	42.68	-8.83	33.85	47.00	-13.15	QP
4		359.1859	39.92	-6.17	33.75	47.00	-13.25	QP
5	*	455.9057	44.00	-2.94	41.06	47.00	-5.94	QP
6		480.5276	41.88	-2.42	39.46	47.00	-7.54	QP

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Polarization :	Vertical
Test Mode	PING IP	Remark:	N/A

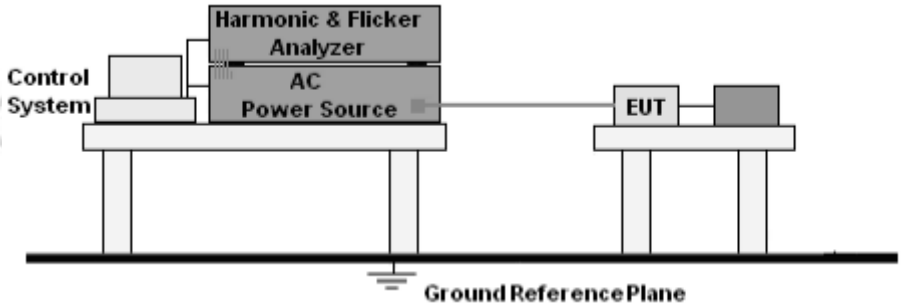
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over	
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB	Detector
1	!	33.7986	43.98	-9.39	34.59	40.00	-5.41	QP
2		59.8588	45.15	-11.76	33.39	40.00	-6.61	QP
3		84.1099	46.72	-14.04	32.68	40.00	-7.32	QP
4		115.7256	43.25	-11.95	31.30	40.00	-8.70	QP
5	*	209.3129	47.29	-11.42	35.87	40.00	-4.13	QP
6	!	455.9057	44.33	-2.94	41.39	47.00	-5.61	QP

Remark:
Factor = Antenna Factor + Cable Loss – Pre-amplifier.

Above 1GHz
The amplitude of spurious emissions which are attenuated by more than 20dB below the permissible value has no need to be reported.

8. HARMONIC CURRENT EMISSION(H)

8.1 Block Diagram of Test Setup



8.2 Limit

EN 61000-3-2:2014 Clause 7.

8.3 Test Procedure

a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.

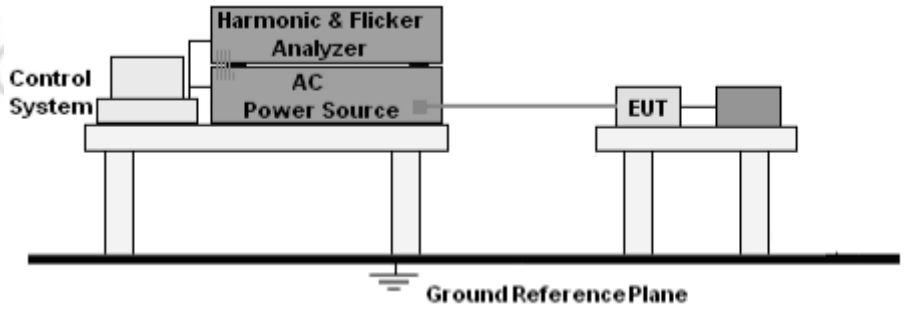
b. The correspondent test program of test instrument to measure the current harmonics emanated from Product was chosen. The measure time shall be not less than the time necessary for the Product to be exercised.

8.4 Test Results

The Product belongs to Class A, and its power is less than 75W, so it deems to fulfil this standard without testing.

9. VOLTAGE FLUCTUATIONS & FLICKER(F)

9.1 Block Diagram of Test Setup



9.2 Limit

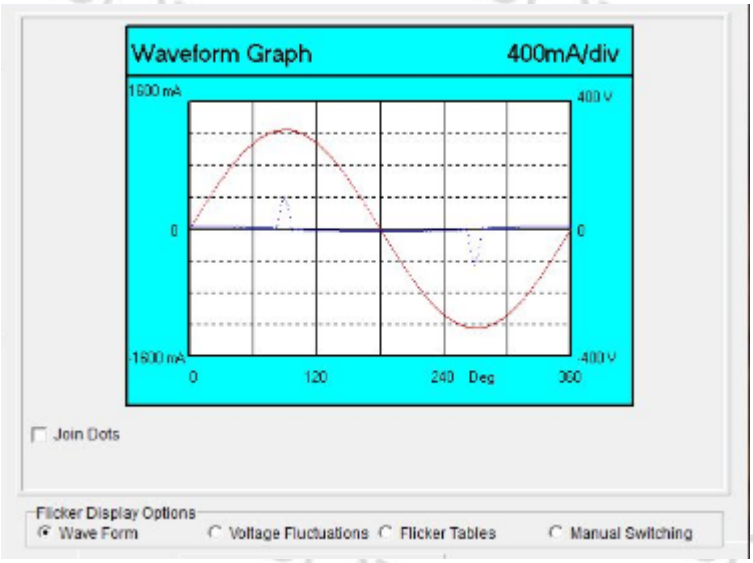
EN 61000-3-3:2013 Clause 5.

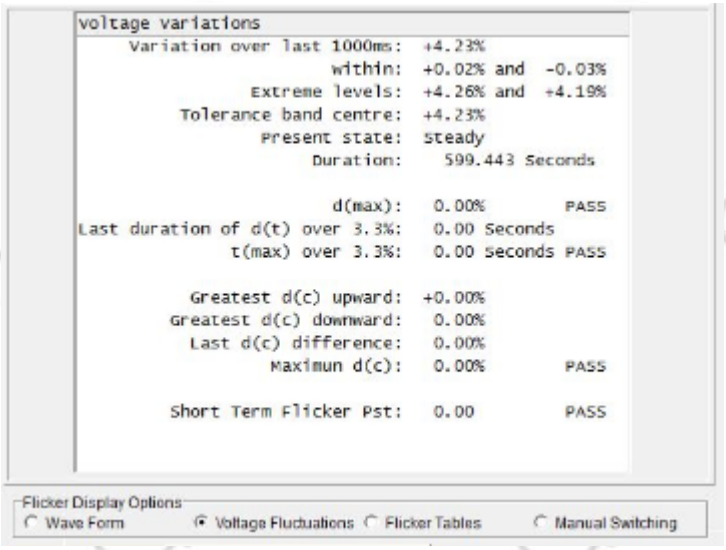
9.3 Test Procedure

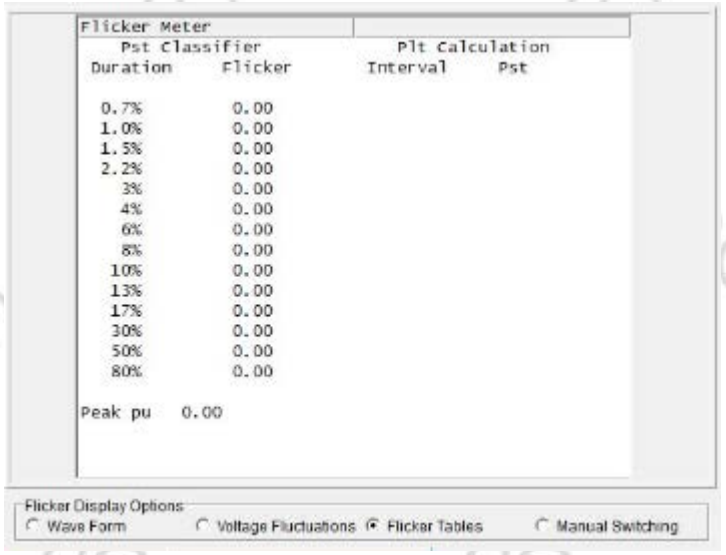
a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.

b. During the flick test, the measure time shall include that part of whole operation cycle in which the Product produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

9.4 Test Results




voltage variations
Variation over last 1000ms: +4.23%
within: +0.02% and -0.03%
Extreme levels: +4.26% and +4.19%
Tolerance band centre: +4.23%
Present state: steady
Duration: 599.443 Seconds
d(max): 0.00% PASS
Last duration of d(t) over 3.3%: 0.00 Seconds
t(max) over 3.3%: 0.00 seconds PASS
Greatest d(c) upward: +0.00%
Greatest d(c) downward: 0.00%
Last d(c) difference: 0.00%
Maximun d(c): 0.00% PASS
Short Term Flicker Pst: 0.00 PASS
Flicker Display Options
Wave Form
Voltage Fluctuations
Flicker Tables
Manual Switching


Flicker Meter
Pst Classifier
Plt Calculation
Duration Flicker Interval Pst
0.7% 0.00
1.0% 0.00
1.5% 0.00
2.2% 0.00
3% 0.00
4% 0.00
6% 0.00
8% 0.00
10% 0.00
13% 0.00
17% 0.00
30% 0.00
50% 0.00
80% 0.00
Peak pu 0.00
Flicker Display Options
Wave Form
Voltage Fluctuations
Flicker Tables
Manual Switching

10. IMMUNITY TEST OF GENERAL THE PERFORMANCE CRITERIA

According To EN 301489 -17standard, The General Performance Criteria As Following:

Criteria	During the test	After the test
A	Shall operate as□intended May show degradation of performance (see note 1) Shall be no loss of function Shall be no unintentional transmissions	Shall operate as intended Shall be no degradation of performance (see note 2) Shall be no loss of function Shall be no loss of stored data or user programmable functions
B	May show loss of function (one or more) May show degradation of performance (see note 1) No unintentional transmissions	Functions shall be self-recoverable Shall operate as intended after recovering Shall be no degradation of performance (see note 2) Shall be no loss of stored data or user programmable functions
C	May be loss of function (one or more)	Functions shall be recoverable by the operator Shall operate as intended after recovering Shall be no degradation of performance (see note 2)

NOTE 1: Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 2: no degradation of performance after the test is understood as any degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

PERFORMANCE FOR TT

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR TR

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR CT

The performance criteria A shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an Acknowledgement (ACK) or Not Acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR CR

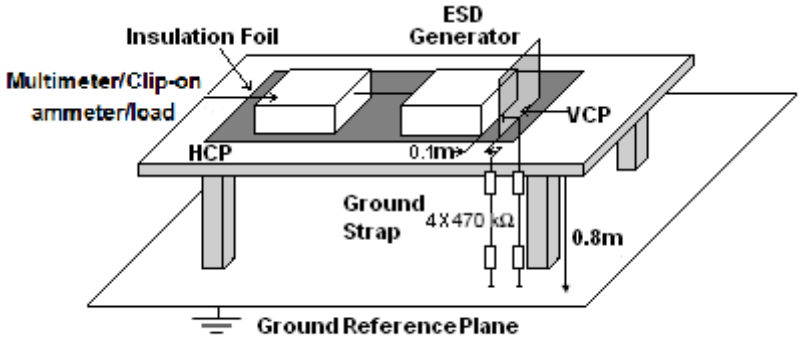
The performance criteria A shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

11. ELECTROSTATIC DISCHARGE (ESD)

11.1 Test Specification

Test Port	:	Enclosure port
Discharge Impedance	:	330 ohm / 150 pF
Discharge Mode	:	Single Discharge
Discharge Period	:	one second between each discharge

11.2 Block Diagram of Test Setup



11.3 Test Procedure

a. Electrostatic discharges were applied only to those points and surfaces of the Product that are accessible to users during normal operation.

b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.

c. The time interval between two successive single discharges was at least 1 second.

d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the Product.

e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.

f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the Product as fast as possible (without causing mechanical damage) to touch the Product. After each discharge, the ESD generator was removed from the Product and re-triggered for a new single discharge. The test was repeated until all discharges were complete.

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11.4 Test Results

Temperature：	26 ℃	Relative Humidity：	54%
Pressure：	101kPa	Test Mode：	WIFI LINK/PING IP

Mode	Air Discharge (Test result)								Contact Discharge (Test result)								Observation	Perform Criteria	Judgment
Test level (kV)	2		4		8		15		2		4		6		8				
Test Location	+	-	+	-	+	-	+	-	+	-	+	-	+	-	+	-			
HCP									A	A	A	A					CT,CR	B	PASS
VCP									A	A	A	A					CT,CR	B	PASS
USB Port									A	A	A	A					CT,CR	B	PASS
enclosure									A	A	A	A					CT,CR	B	PASS
Connection port	A	A	A	A	A	A											CT,CR	B	PASS

Note:

1) P/N denotes the Positive/Negative polarity of the output voltage.
2) Test condition:
Direct / Indirect (HCP/VCP) discharges: Minimum 50 times (Positive/Negative) at each point. Air discharges: Minimum 10 times (Positive/Negative) at each point.
3) N/A - denotes test is not applicable in this test report
4)There was not any unintentional transmission in standby mode

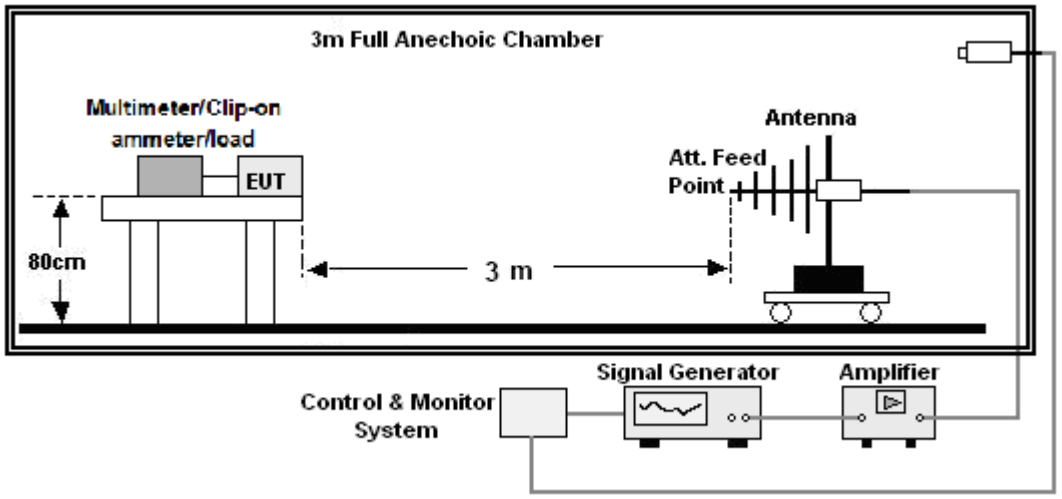
12. CONTINUOUS RF ELECTROMAGNETIC FIELD DISTURBANCES(RS)

12.1 Test Specification

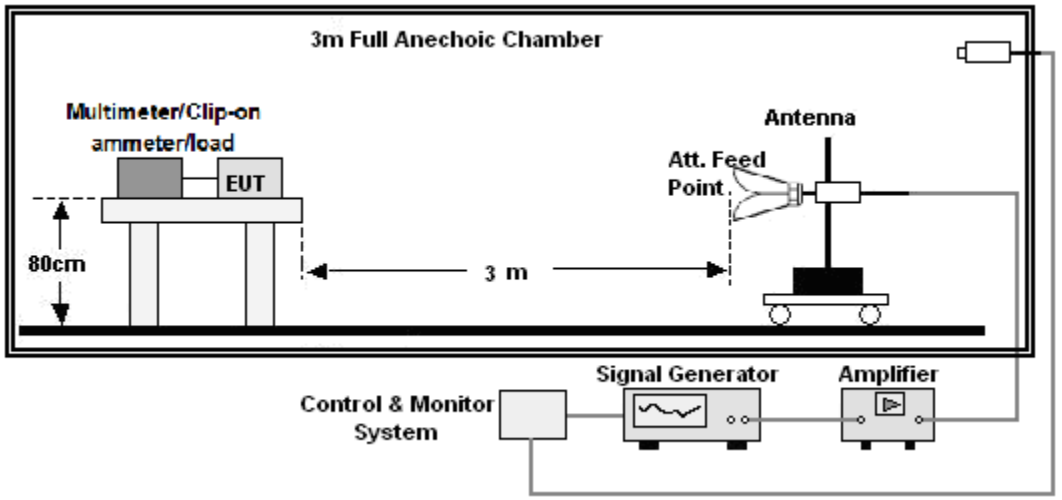
Test Port	:	Enclosure port
Step Size	:	1%
Modulation	:	1kHz, 80% AM
Dwell Time	:	1 second
Polarization	:	Horizontal & Vertical

12.2 Block Diagram of Test Setup

Below 1GHz:



Above 1GHz:



12.3 Test Procedure

a. The testing was performed in a fully-anechoic chamber. The transmit antenna was located at a distance of 3 meters from the Product.

b. The frequency range is swept from 80MHz to 6000MHz,with the signal 80% amplitude modulated with a 1 kHz sine wave,and the step size was 1%.

c. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to be able to respond, but should not exceed 5 s at each of the frequencies during the scan.

d. The test was performed with the Product exposed to both vertically and horizontally polarized fields on each of the four sides.

e. For Broadcast reception function:Group 2 not apply in this test.

12.4 Test Results

Temperature：	26 ℃	Relative Humidity：	54%
Pressure：	101kPa	Test Mode：	WIFI LINK

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Observation	Perform Criteria	Test Result	Judgment
80~6000	H / V	3 V/m (rms) AM Modulated 1000Hz, 80%	Front	CT,CR	A	A	PASS
			Rear				
			Left				
			Right				

Note:

1) P/N denotes the Positive/Negative polarity of the output voltage.
2) N/A - denotes test is not applicable in this test report.
3) There was no change operated with initial operating during the test.
4) There was not any unintentional transmission in standby mode

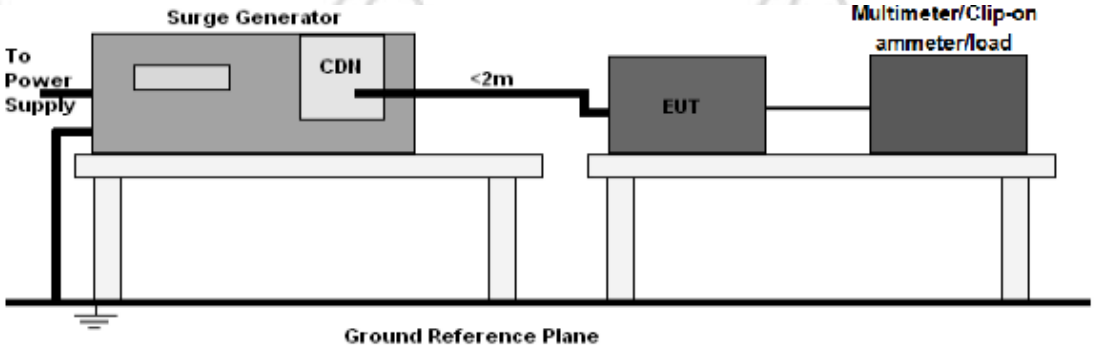
13. ELECTRICAL FAST TRANSIENTS/BURST (EFT)

13.1 Test Specification

Test Port	:	input AC/DC power port
Impulse Frequency	:	5 kHz
Impulse Wave-shape	:	5/50 ns
Burst Duration	:	15 ms
Burst Period	:	300 ms
Test Duration	:	2 minutes per polarity

13.2 Block Diagram of EUT Test Setup

For input AC power port:



13.3 Test Procedure

a. The Product and support units were located on a non-conductive table above ground reference plane.

b. A 0.5m-long power cord was attached to Product during the test.

13.4 Test Results

Temperature：	26 ℃	Relative Humidity：	54%
Pressure：	101 KPa	Test Mode：	WIFI LINK

Coupling Line		Test level (KV)l								Obser vation	Perform Criteria	Test Result	Judg ment
		0.5		1		2		4					
		+	-	+	-	+	-	+	-				
AC Line	L	A	A	A	A					CT,CR	B	A	PASS
	N	A	A	A	A							A	PASS
	L+N	A	A	A	A							A	PASS
	PE												PASS
	L+PE												PASS
	N+PE												PASS
	L+N+PE												PASS
DC Line													
Signal Line													

Note:

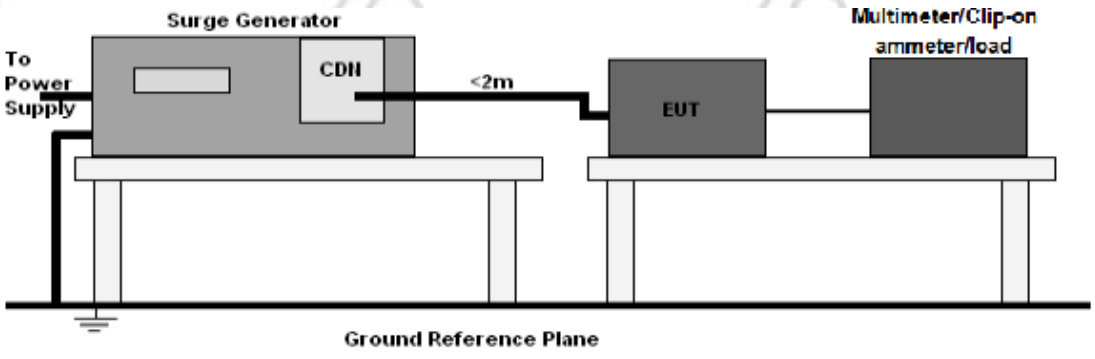
1) P/N denotes the Positive/Negative polarity of the output voltage.
2) N/A - denotes test is not applicable in this test report.
3) There was not any unintentional transmission in standby mode

14. SURGES IMMUNITY TEST

14.1 Test Specification

Test Port	:	input AC/DC power port
Wave-Shape	:	Open Circuit Voltage - 1.2 / 50 us Short Circuit Current - 8 / 20 us
Pulse Repetition Rate	:	1 pulse / min.
Phase Angle	:	0° / 90° / 180° / 270°
Test Events	:	5 pulses (positive & negative) for each polarity

14.2 Block Diagram of EUT Test Setup



14.3 Test Procedure

a. The surge is to be applied to the Product power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave.

b. The power cord between the Product and the coupling/decoupling networks shall be 2 meters in length (or shorter). Interconnection line between the Product and the coupling/decoupling networks shall be 2 meters in length (or shorter).

14.4 Test Result

Temperature：	26 ℃	Relative Humidity：	54%
Pressure：	101 kPa	Test Mode：	WIFI LINK/PING IP

Coupling Line			Test level (KV) Test Result								Observation	Perform Criteria	Judgment
			0.5		1		2		4				
			+	-	+	-	+	-	+	-			
AC Line	L-N	0°	A	A	A	A					CT,CR	A	PASS
		90°	A	A	A	A							
		180°	A	A	A	A							
		270°	A	A	A	A							
	L-PE	0°											PASS
		90°											
		180°											
		270°											
	N-PE	0°											PASS
		90°											
		180°											
		270°											
DC Line													
Signal Line													

Note:

1) Polarity and Numbers of Impulses：5 Pst / Ngt at each tested mode
2) N/A - denotes test is not applicable in this Test Report
3) There was not any unintentional transmission in standby mode

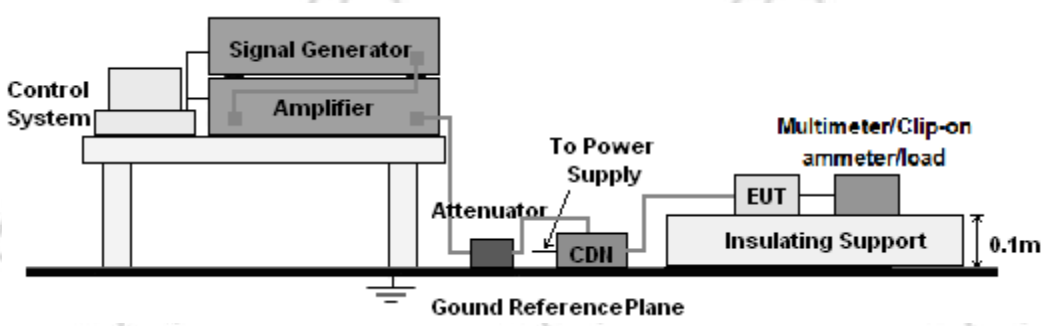
15. CONTINUOUS INDUCED RF DISTURBANCES (CS)

15.1 Test Specification

Test Port	:	input DC. power port analogue/digital data port
Step Size	:	1%
Modulation	:	1kHz, 80% AM
Dwell Time	:	1 second

15.2 Block Diagram of EUT Test Setup

For input AC power port:



15.3 Test Procedure

For input ACpower port:

a. The Product and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.

b. The frequency range is swept from 150 kHz to 10MHz, 10MHz to 30MHz, 30MHz to 80MHz with the signal 80% amplitude modulated with a 1 kHz sine wave, and the step size was 1% of fundamental.

c. The dwell time at each frequency shall be not less than the time necessary for the Product to be able to respond.

15.4 Test Result

Temperature：	26 ℃	Relative Humidity：	54%
Pressure：	101kPa	Test Mode：	WIFI LINK/PING IP

Test Ports (Mode)	Freq. Range (MHz)	Field Strength Azimuth	Observation	Perform Criteria	Test Result	Judgment
Input/ Output AC. Power Port	0.15-80	3 V/m (rms) AM Modulated 1000Hz, 80%	**CT,CR**	A	A	PASS
Input/ Output DC. Power Port	0.15-80		N/A	N/A	N/A	N/A
Signal Line	0.15-80		N/A	N/A	N/A	N/A

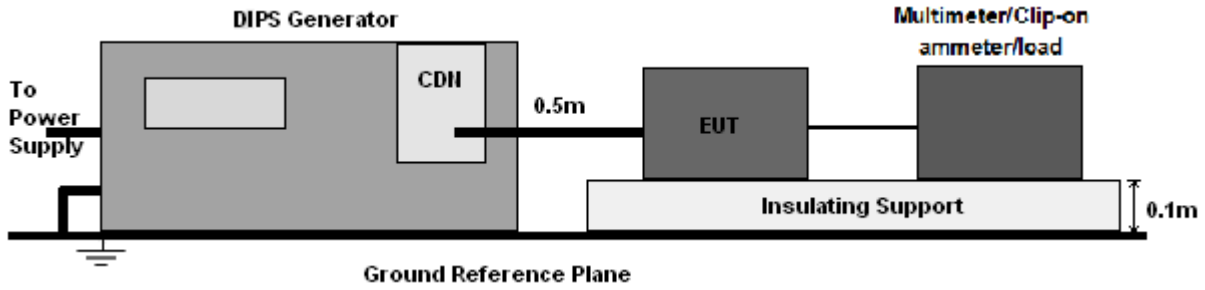
Note: “A” stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.

16. VOLTAGE DIPS AND INTERRUPTIONS (DIPS)

16.1 Test Specification

Test Port	:	input AC/DC power port
Phase Angle	:	0°, 180°
Test cycle	:	3 times

16.2 Block Diagram of EUT Test Setup



16.3 Test Procedure

a. The Product and support units were located on a non-conductive table above ground floor.

b. Set the parameter of tests and then perform the test software of test simulator.

c. Conditions changes to occur at 0 degree crossover point of the voltage waveform.

16.4 Test Result

Temperature：	26 ℃	Relative Humidity：	54%
Pressure：	101 kPa	Test Mode：	WIFI LINK/PING IP

Voltage Reduction	Duration (ms)	Observation	Perform Criteria	Test Result	Judgment
Voltage dip 0%	10	**TT, TR**	**B**	**A**	**PASS**
Voltage dip 0%	20	**TT, TR**	**B**	**B**	**PASS**
Voltage dip 70%	500	**TT, TR**	**B**	**B**	**PASS**
Voltage interruptions	5000	**TT, TR**	**C**	**B**	**PASS**

Note:

1) There was not any unintentional transmission in standby mode

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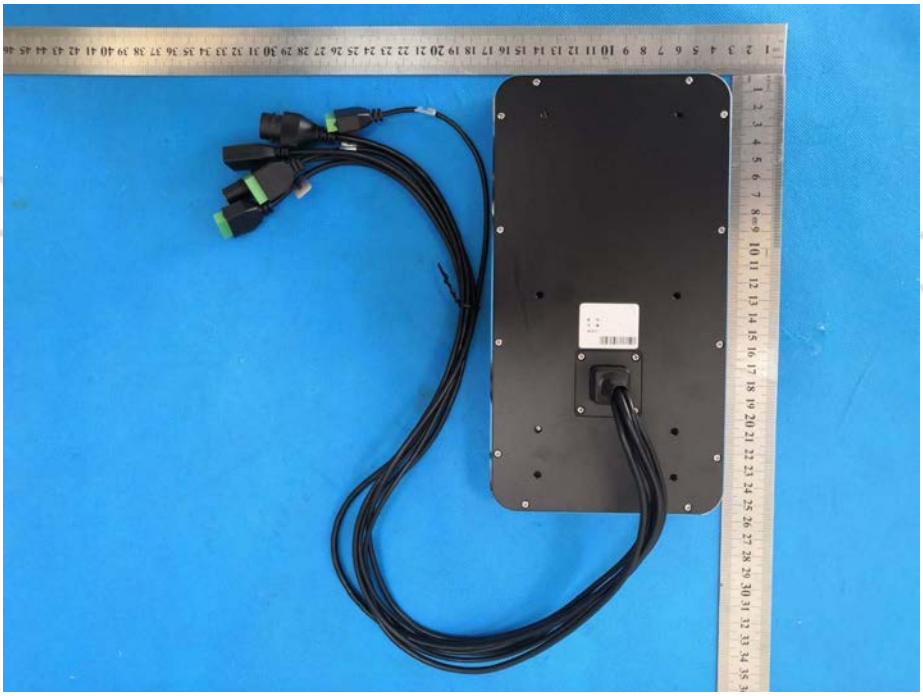
17. EUT PHOTOGRAPHS

EUT Photo 1

EUT Photo 2

EUT Photo 3

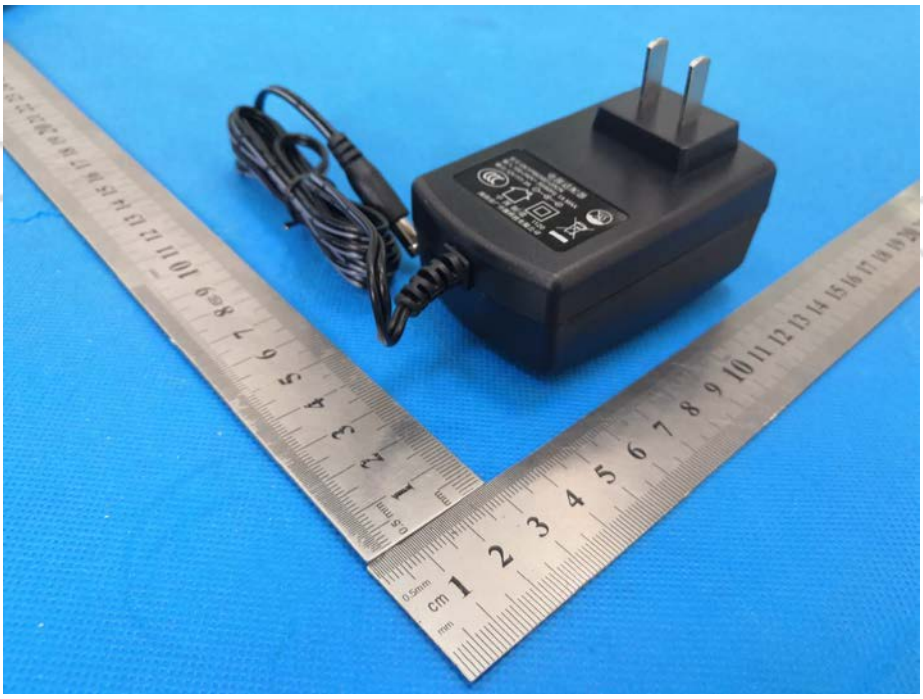


EUT Photo 4

EUT Photo 5

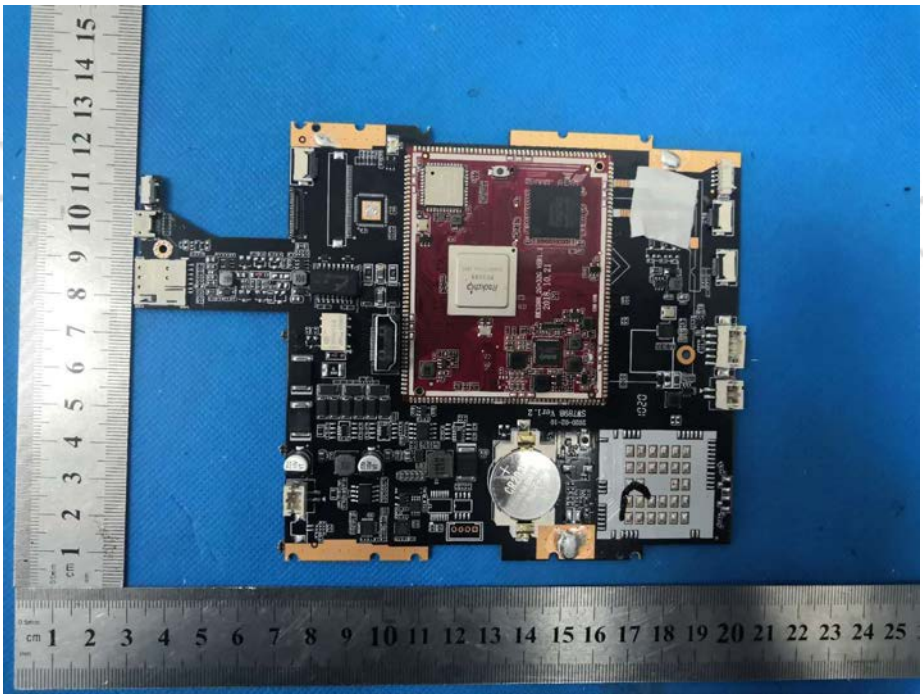
EUT Photo 6

EUT Photo 7

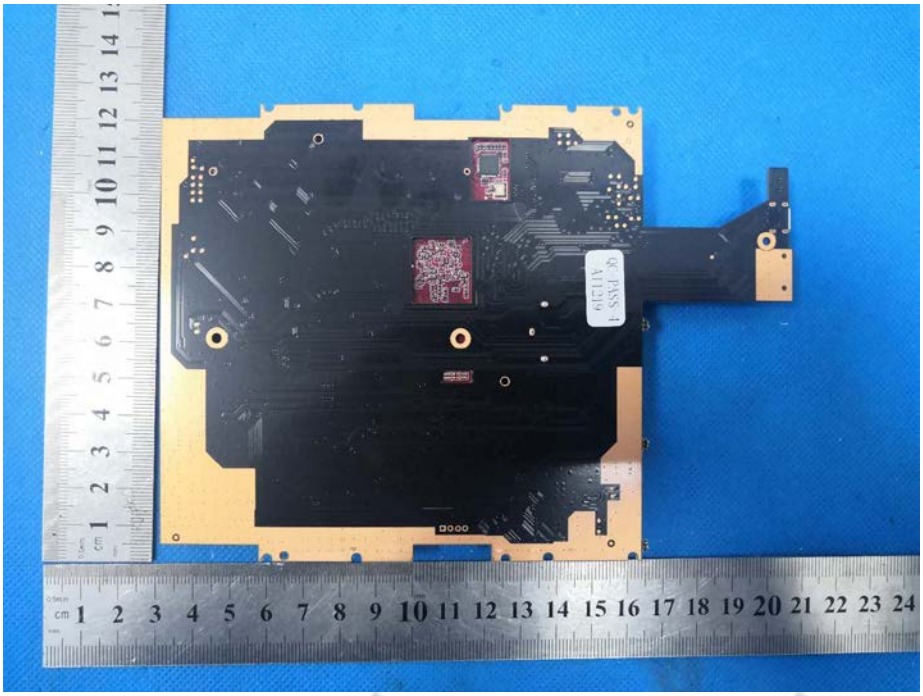


EUT Photo 8

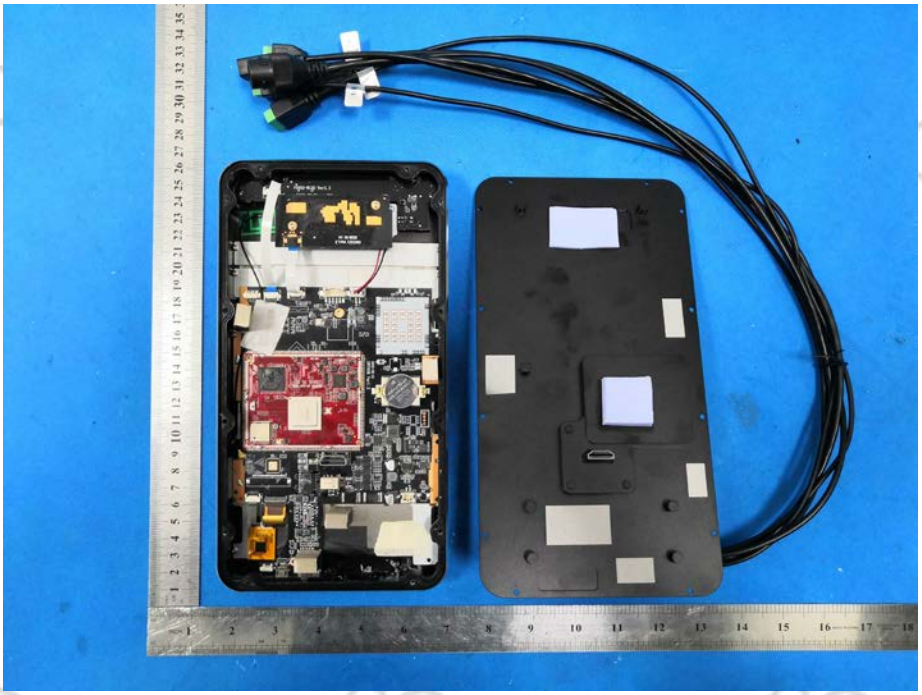
EUT Photo 9



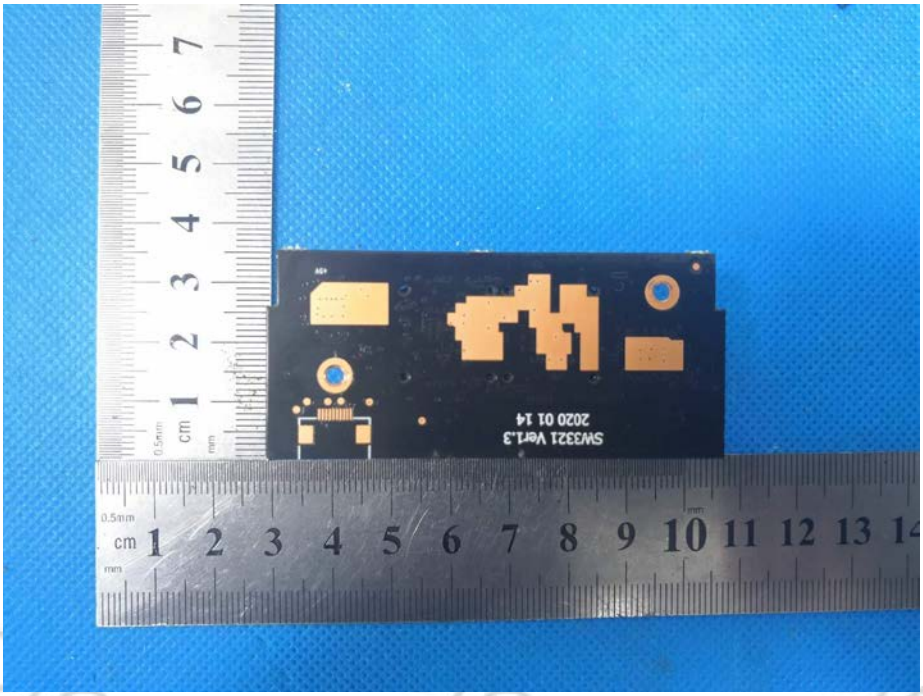
EUT Photo 10



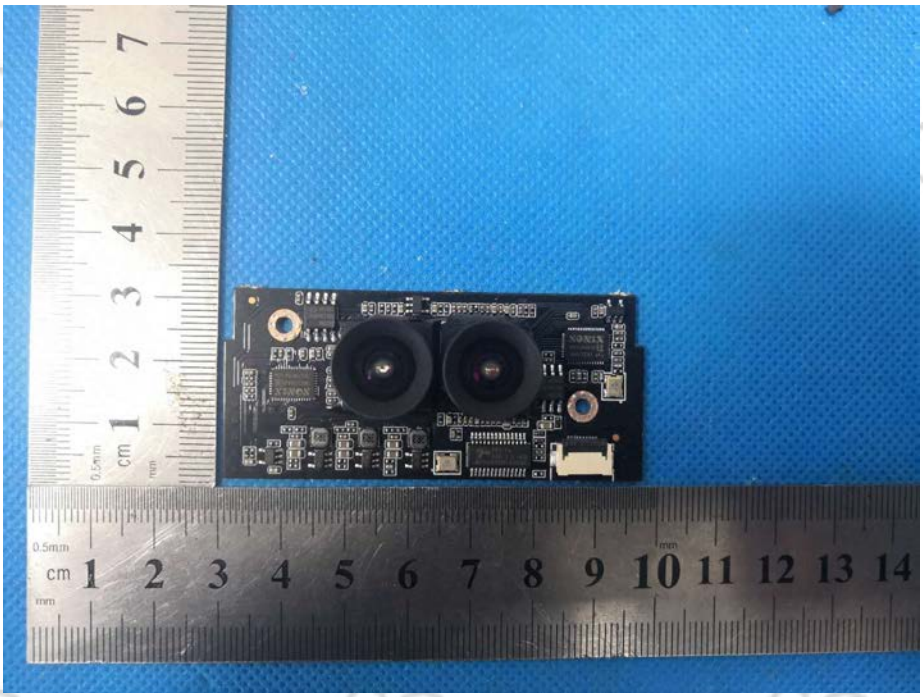
EUT Photo 11



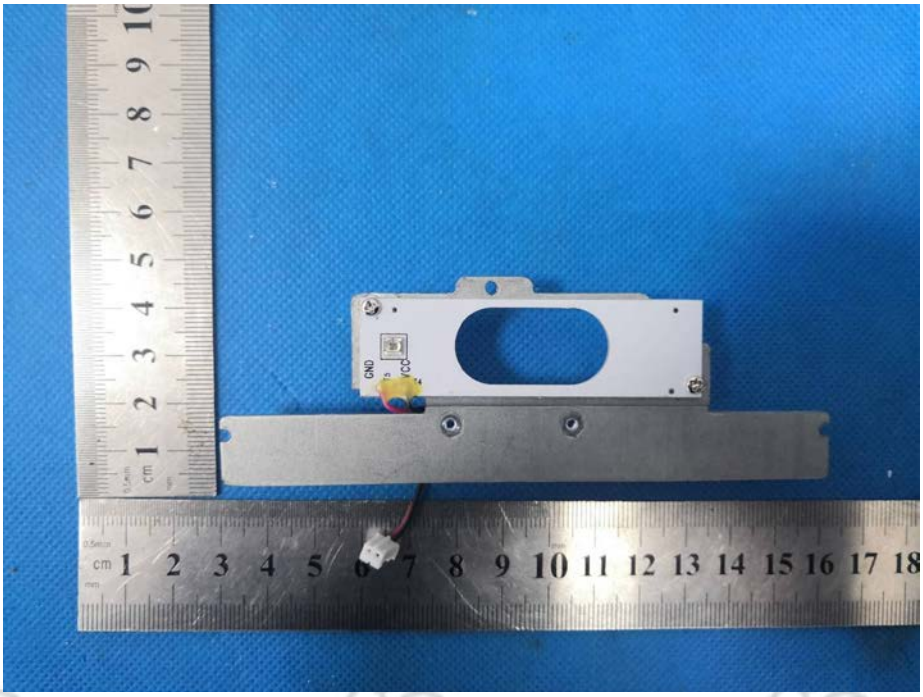
EUT Photo 12



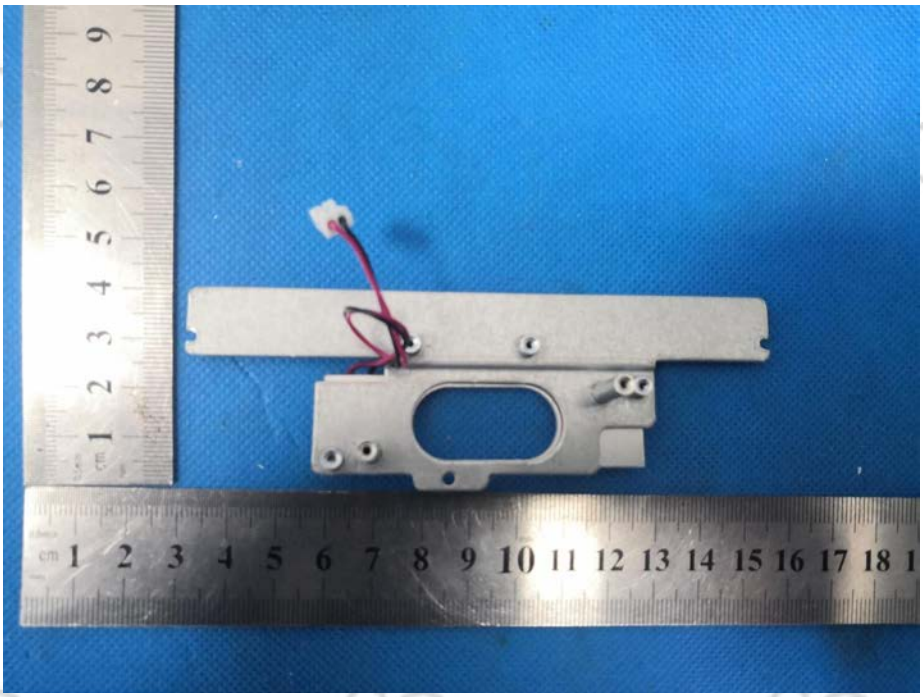
EUT Photo 13



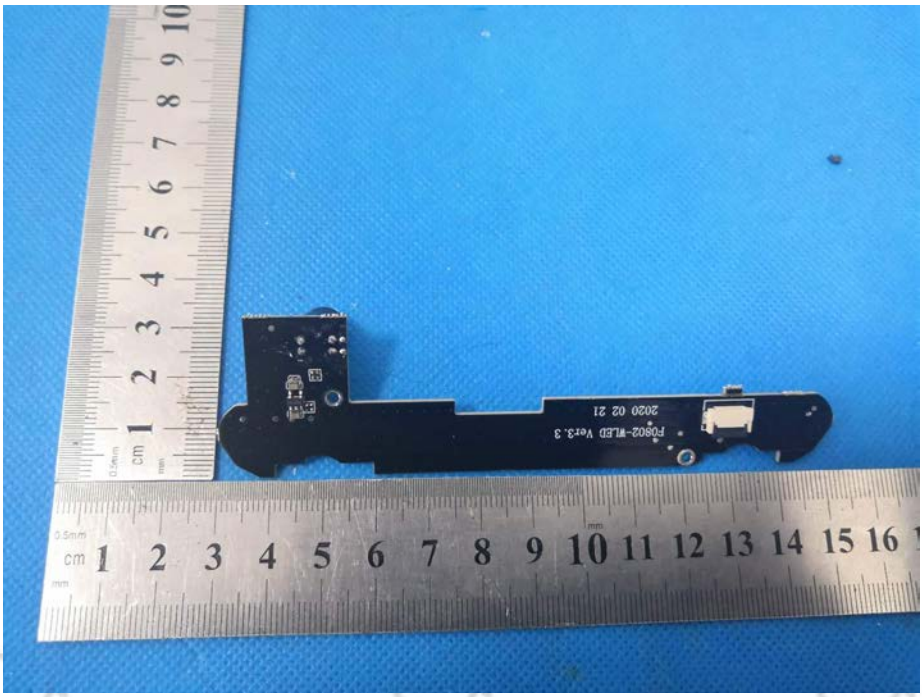
EUT Photo 14



EUT Photo 15

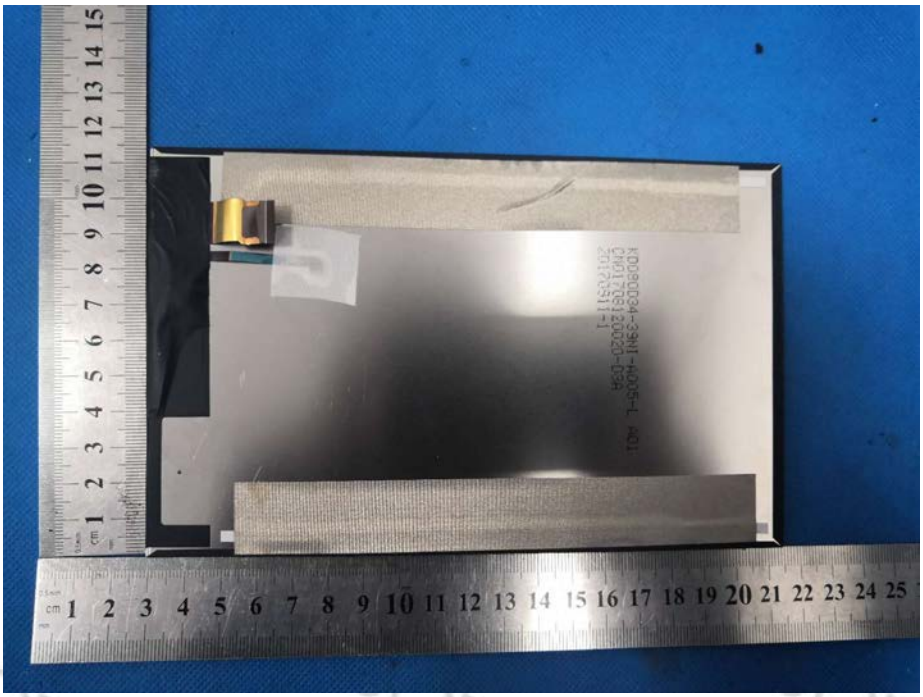


EUT Photo 16



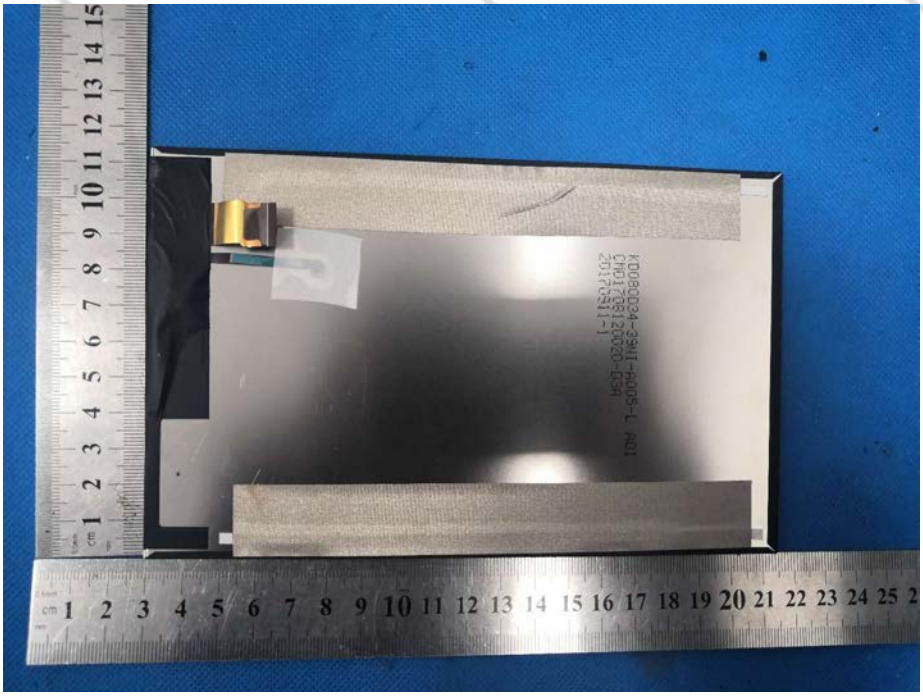
EUT Photo 17

EUT Photo 18



EUT Photo 19

EUT Photo 20

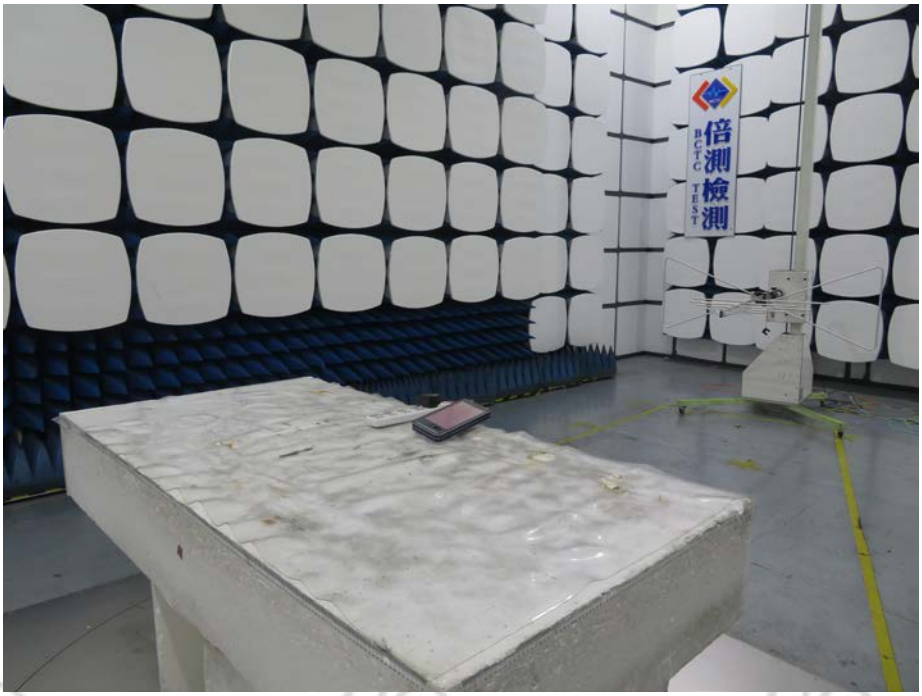


EUT Photo 21

18. EUT TEST SETUP PHOTOGRAPHS

Conducted emissions

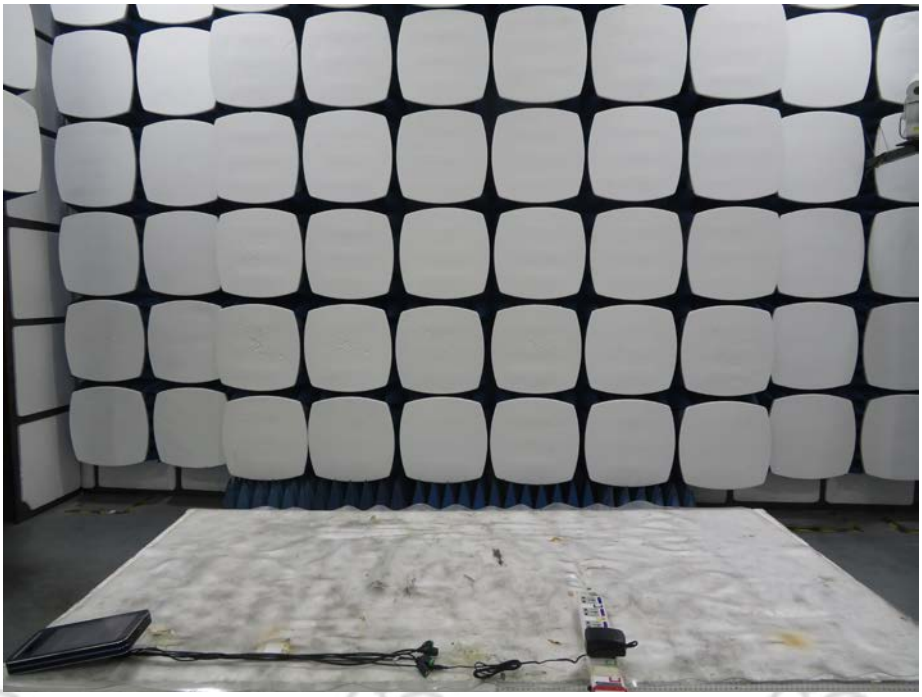
Radiated emissions



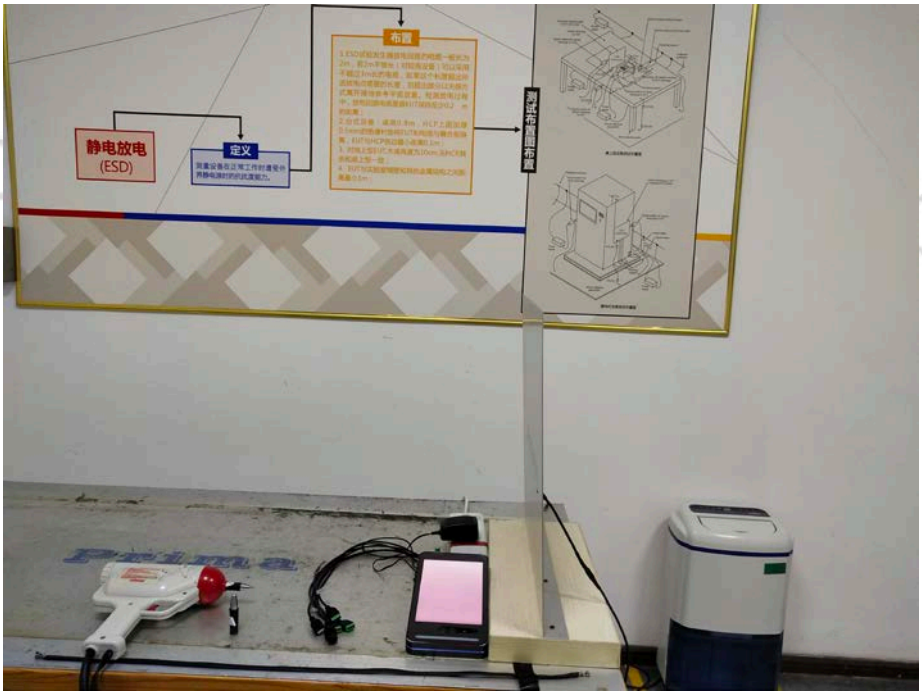
H/F


测试布置图布置
AC Mains
AC Power Source
EUT
LAPLACE INSTRUMENTS LTD

RS



ESD



EFT/DIPS/SURGE

CS

※※※※※ END OF REPORT ※※※※※